



UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE
United States Patent and Trademark Office
Address: COMMISSIONER FOR PATENTS
P.O. Box 1450
Alexandria, Virginia 22313-1450
www.uspto.gov

APPLICATION NO.	ISSUE DATE	PATENT NO.	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/009,959	05/01/2007	7210276	3827.088	3236

30448 7590 04/11/2007
AKERMAN SENTERFIT
P.O. BOX 3188
WEST PALM BEACH, FL 33402-3188

ISSUE NOTIFICATION

The projected patent number and issue date are specified above.

Determination of Patent Term Adjustment under 35 U.S.C. 154 (b) (application filed on or after May 29, 2000)

The Patent Term Adjustment is 515 day(s). Any patent to issue from the above-identified application will include an indication of the adjustment on the front page.

If a Continued Prosecution Application (CPA) was filed in the above-identified application, the filing date that determines Patent Term Adjustment is the filing date of the most recent CPA.

Applicant will be able to obtain more detailed information by accessing the Patent Application Information Retrieval (PAIR) WEB site (<http://pair.uspto.gov>).

Any questions regarding the Patent Term Extension or Adjustment determination should be directed to the Office of Patent Legal Administration at (571)-272-7702. Questions relating to issue and publication fee payments should be directed to the Customer Service Center of the Office of Patent Publication at (571)-272-4200.

APPLICANT(s) (Please see PAIR WEB site <http://pair.uspto.gov> for additional applicants):

Elke Kraft, Bad Urach, GERMANY;
Thorsten Kraus, Bad Urach, GERMANY;
Juergen Koessler, Bad Urach, GERMANY;
Ralf Heinzmann, Reutlingen, GERMANY;
Roland Schneider, Ulm, GERMANY;
Hans-Christoph Thielemann, Nuertingen, GERMANY;
Morten Muschak, Munderkingen, GERMANY;
Norbert Singer, Zuerich, SWITZERLAND;
Michael Geissbuehler, Schwarzenberg, SWITZERLAND;
Josef Wolf, Zuerich, SWITZERLAND;
Beat Maerki, Ruefenach, SWITZERLAND;
Dieter Geng, Daellikon, SWITZERLAND;
Ueli Pfenninger, Ch-8804, SWITZERLAND;
Philippe De Vriendt, Paris, FRANCE;
Fabio Guerrini, Milano, ITALY;